

# INTERNATIONAL STANDARD



**Electromagnetic compatibility (EMC) –  
Part 4-24: Testing and measurement techniques – Test methods for protective  
devices for HEMP conducted disturbance**



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# INTERNATIONAL STANDARD



Electromagnetic compatibility (EMC) –  
Part 4-24: Testing and measurement techniques – Test methods for protective  
devices for HEMP conducted disturbance

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**Electromagnetic compatibility (EMC) –  
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## CONTENTS

FOREWORD.....	5
INTRODUCTION.....	7
1 Scope.....	8
2 Normative references .....	8
3 Terms, definitions and abbreviated terms .....	8
3.1 Terms and definitions.....	8
3.2 Abbreviated terms.....	10
4 Test methods for protective devices (excluding filter) for conducted disturbance .....	10
4.1 General.....	11
4.2 Test setup.....	11
4.3 Pulse generator .....	11
4.4 Launching line .....	11
4.5 Test fixtures.....	12
4.5.1 General .....	12
4.5.2 Type A fixtures .....	12
4.5.3 Type B fixtures .....	12
4.6 Termination.....	13
4.7 Oscilloscope .....	14
4.8 Test procedure.....	14
4.8.1 Adjustment of the pulse generator .....	14
4.8.2 Verification procedures .....	14
4.8.3 Test .....	15
4.8.4 Final examination of the DUT.....	15
4.9 Referring to this standard.....	15
5 Measurement method for HEMP combination filters.....	16
5.1 Verification setup .....	16
5.2 Measurement setup .....	16
5.3 Measurement instrument .....	17
5.3.1 Pulse generators .....	17
5.3.2 Oscilloscope .....	19
5.3.3 Current sensors .....	19
5.3.4 Test leads.....	19
5.4 Test modes required .....	19
5.5 Measurement procedure .....	21
5.5.1 General .....	21
5.5.2 Verification of pulses .....	21
5.5.3 Measurement procedure .....	21
5.6 Evaluation of test results.....	22
5.7 Test report.....	23
6 Measurement method of HEMP protectors for RF antenna ports.....	23
6.1 General.....	23
6.2 Test level and injection waveform specification .....	24
6.3 Verification of test level.....	24
6.4 Measurement procedure .....	25
6.5 Evaluation of test results.....	25
6.6 Test report.....	26

Annex A (informative) Investigation for the establishment of a measurement setup.....	27
A.1 General.....	27
A.2 Variation of the cable connected for the measurement of short-circuit current.....	27
A.3 Variation of the length of the cable L2 connected for the measurement of residual current.....	30
A.4 Variation of load impedance and cable length for connection between load and ground .....	34
A.5 Variation of the cable length between load and ground .....	36
Annex B (informative) Test method for the quantitative determination of the direct response behaviours of a coaxial surge protector .....	39
Annex C (informative) Residual measurements for antenna port protectors.....	43
C.1 Evaluating the required protection for RF antenna ports.....	43
C.2 Evaluating the required protection for RF antenna ports.....	45
Bibliography.....	48
Figure 1 – Test setup for testing protective devices .....	11
Figure 2 – Example of a type B test fixture (universal) .....	14
Figure 3 – Typical setup for verification of the pulse test level .....	16
Figure 4 – Example of test setup using one or two shielded enclosures .....	17
Figure 5 – Example of test setup using a shielded enclosure .....	17
Figure 6 – Double exponential waveform .....	19
Figure 7 – Example of wiring setup of a single line DUT .....	20
Figure 8 – Example of wiring setup for a mutually coupled multi-line DUT .....	20
Figure 9 – Typical verification setup.....	24
Figure 10 – Typical measurement setup.....	25
Figure A.1 – Setup for calibration.....	27
Figure A.2 – Peak current calibration results with 9 mm <sup>2</sup> cables: 1 000 A ± 4 % .....	28
Figure A.3 – Rise time calibration results with 9 mm <sup>2</sup> cables .....	29
Figure A.4 – FWHM calibration results with 9 mm <sup>2</sup> cables .....	29
Figure A.5 – Peak current calibration results with 4 mm <sup>2</sup> cables: 1 000 A ± 8 % .....	29
Figure A.6 – Rise time calibration results with 4 mm <sup>2</sup> cables .....	30
Figure A.7 – FWHM calibration results with 4 mm <sup>2</sup> cables .....	30
Figure A.8 – Measurement setup for residual current .....	31
Figure A.9 – Measurement result of peak current with variation of measurement cable L2.....	32
Figure A.10 – Measurement result of peak rate of rise with variation of measurement cable L2.....	32
Figure A.11 – Measurement result of root action with variation of measurement cable L2.....	32
Figure A.12 – Variation of the position of current sensor 2 on the measurement cable L2.....	33
Figure A.13 – Peak current with variation of cable L2 and at different positions .....	33
Figure A.14 – Peak rate of rise with variation of cable L2 and at different positions .....	34
Figure A.15 – Root action with variation of cable L2 and at different positions .....	34
Figure A.16 – Measurement result of peak current with variation of load impedance .....	35
Figure A.17 – Measurement result of peak rate of rise with variation of load impedance .....	35

Figure A.18 – Measurement result of root action with variation of load impedance.....	36
Figure A.19 – Variation of the length of cable L3 connected between load and ground plane.....	36
Figure A.20 – Measurement result of peak current with variation of measurement cable L3.....	37
Figure A.21 – Measurement result of peak rate of rise with variation of measurement cable L3.....	37
Figure A.22 – Measurement result of root action with variation of measurement cable L3.....	38
Figure B.1 – Test setup with a power divider for testing protective devices.....	39
Figure B.2 – Waves propagating along the branches.....	40
Figure B.3 – Simplified test setup for testing protective devices.....	41
Figure C.1 – Transceiver with antenna port shown.....	43
Figure C.2 – Protectors on RX and TX signal path internal to the transceiver after the RF port.....	44
Figure C.3 – Protector internal to equipment for RX side protection and outside the equipment at the antenna port for transmit and port protection.....	44
Figure C.4 – N-type RF antenna port protector using GDTs.....	45
Figure C.5 – Typical antenna system with RF-HEMP protector (DUT).....	46
Table 1 – Overview of conducted early-time HEMP (CEP) test requirements defined in other specifications.....	18
Table 2 – Overview of conducted intermediate-time HEMP (CIP) test requirements defined in other specifications.....	18
Table 3 – Test mode and DUT wiring setup.....	21
Table 4 – Performance criteria of filter against early-time HEMP – AC power port with nominal load 2 Ω.....	22
Table 5 – Performance criteria of filter against early-time HEMP – DC power port with nominal load 2 Ω.....	22
Table 6 – Performance criteria of filter against early-time HEMP – Signal, data and control port with nominal load 50 Ω.....	23
Table 7 – Pulsed current injection test level for RF antenna ports.....	24
Table 8 – Performance criteria of filters against early-time HEMP – RF antenna ports.....	25
Table A.1 – Measurement results for the waveform calibration of short-circuit current.....	28
Table A.2 – Measurement results for variation of the cable length at the measurement points.....	31
Table A.3 – Measurement results for variation of the load impedance.....	35
Table A.4 – Measurement results for variation of the cable length between load and ground.....	37

INTERNATIONAL ELECTROTECHNICAL COMMISSION

**ELECTROMAGNETIC COMPATIBILITY (EMC) –**

**Part 4-24: Testing and measurement techniques –  
Test methods for protective devices  
for HEMP conducted disturbance**

FOREWORD

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**IEC 61000-4-24 edition 2.1 contains the second edition (2015-11) [documents 77C/245/FDIS and 77C/250/RVD] and its amendment 1 (2023-08) [documents 77C/330/FDIS and 77C/331/RVD].**

**In this Redline version, a vertical line in the margin shows where the technical content is modified by amendment 1. Additions are in green text, deletions are in strikethrough red text. A separate Final version with all changes accepted is available in this publication.**

International Standard IEC 61000-4-24 has been prepared by subcommittee 77C: High power transient phenomena, of IEC technical committee 77: Electromagnetic compatibility.

It forms Part 4-24 of IEC 61000. It has the status of a basic EMC publication in accordance with IEC Guide 107.

This second edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) A new Clause 5: Measurement method for HEMP combination filters, which contains 5.1 Verification setup, 5.2 Measurement setup, 5.3 Measurement instrument, 5.4 Test mode, 5.5 Measurement procedures, 5.6 Evaluation of test results, which introduced performance criteria of filter, and 5.7 Test report.
- b) A new informative Annex A: Investigation for the establishment of a measurement setup, which was based on Clause 5.
- c) A new informative Annex B: Test method for the quantitative determination of the direct response behaviours of a coaxial surge protector.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 61000 series, published under the general title *Electromagnetic compatibility (EMC)*, can be found on the IEC website.

The committee has decided that the contents of this document and its amendment will remain unchanged until the stability date indicated on the IEC website under [webstore.iec.ch](http://webstore.iec.ch) in the data related to the specific document. At this date the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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## INTRODUCTION

This standard is part of the IEC 61000 series of standards, according to the following structure:

### Part 1: General

General considerations (introduction, fundamental principles)

Definitions, terminology

### Part 2: Environment

Description of the environment

Classification of the environment

Compatibility levels

### Part 3: Limits

Emission limits

Immunity limits

### Part 4: Testing and measurement techniques

Measurement techniques

Testing techniques

### Part 5: Installation and mitigation guidelines

Installation guidelines

Mitigation methods and devices

### Part 6: Generic standards

### Part 9: Miscellaneous

Each part is further subdivided into several parts, published either as international standards, as technical specifications or technical reports, some of which have already been published as sections. Others will be published with the part number followed by a dash and a second number identifying the subdivision (example: IEC 61000-6-1).

The IEC has initiated the preparation of standardized methods to protect civilian society from the effects of high power electromagnetic (HPEM) environments. Such effects could disrupt systems for communications, electric power, information technology, etc.

This part of IEC 61000 is an international standard that establishes the required test procedures for protective devices for HEMP conducted disturbance, such as gas discharge tubes, varistors, two-port SPDs and HEMP combination filters.

The application of this standard is, however, not dependent on access to other sections and parts of the IEC 61000, except for those specifically referred to.

## ELECTROMAGNETIC COMPATIBILITY (EMC) –

### Part 4-24: Testing and measurement techniques – Test methods for protective devices for HEMP conducted disturbance

#### 1 Scope

This part of IEC 61000 deals with methods for testing protective devices for HEMP conducted disturbance. It includes two-terminal elements, such as gas discharge tubes, varistors, and two-port SPDs, such as HEMP combination filters. It covers testing of voltage breakdown and voltage-limiting characteristics but also methods to measure the residual voltage and/or the residual current, peak rate of rise and root action for the case of very fast changes of voltage and current as a function of time.

This standard does not cover insertion loss measurement methods.

#### 2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 61000-2-10:2021, *Electromagnetic compatibility (EMC) – Part 2-10: Environment – Description of HEMP environment – Conducted disturbance*

#### 3 Terms, definitions and abbreviated terms

For the purposes of this document, the following terms, definitions and abbreviated terms apply.

##### 3.1 Terms and definitions

###### 3.1.1

###### **feed-through device**

two-port device, which is designed to feed a signal through an electromagnetic barrier (shield)

Note 1 to entry: Typically it is in good electrical contact with the barrier and has one port on each side of the barrier, thus maintaining the isolation of the barrier.

###### 3.1.2

###### **gas discharge tube**

###### **GDT**

device with two or three metal electrodes hermetically sealed so that gas mixture and pressure are under control, and designed to protect apparatus or personnel from high transient voltages

###### 3.1.3

###### **HEMP**

###### **high-altitude electromagnetic pulse**

electromagnetic pulse produced by a nuclear explosion outside the earth's atmosphere

Note 1 to entry: Typically above an altitude of 30 km.